

<b>Notice of References Cited</b>	Application/Control No. 10/583,688		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner YEWEBDAR T. TADESSE		Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,808,755	10-2004	Miyamoto et al.	427/446
*	B	US-5,302,414	04-1994	Alkhimov et al.	427/192
	C	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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